Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,678	TSUJI, TAKASHI	
Examiner	Art Unit	
Lun-See Lao	2643	

	SEAR	CHED	
Class	Subclass	Date	Examiner
379	93.02	515/05	LIS
	93,1		
	93,32		
_	93.34		
	100,01		
	243		
	201.05 201.05 900-3		
	210.02		
709	217	5/10/05	L.S.
	219.227	_	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
CHAN WING	5/10/0	5 6.5.
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